

Application/Conf	trol	No.
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Applicant(s)/Patent under Reexamination

Art Unit

LEE ET AL.

10/040,118
Examiner

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Angela Ortiz

1732

SEARCHED				
Class	Subclass	Date	Examiner	
264	104, 105 139	11/1/2004	AO	
	250, 254			
	267			
	273			
29	852			
	830			
	846			
427	97.2			
	97.7			
	282			
			,	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
264	104, 105	11/1/2004	AO		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST and WEST	11/1/2004	AO	